

**Notice of References Cited**

Application/Control No.

10/066,716

Applicant(s)/Patent Under  
Reexamination  
IIDA ET AL.

Examiner

Patricia T. Nguyen

Art Unit

2817

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,006,821	04-1991	Tam, Ambrose W. C.	333/116
	B	US-3,999,150	12-1976	Caragliano et al.	333/116
	C	US-6,483,398B2	11-2002	Nagamori et al.	333/116
	D	US-6,472,950B1	10-2002	London, Simon Y.	333/125
	E	US-5,994,985	11-1999	Pehlke et al.	334/14
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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